Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/771,590	CHEN ET AL.	
Examiner	Art Unit	
DAVID Y. ENG	2155	

SEARCHED			
Class	Subclass	Date	Examiner
			·

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
update	1/8/2008	DE
	·	